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Chang-Cheng Hung, Hsin-chu, TAIWAN; Hung-Chang Hsieh, Hsinchu city, TAIWAN; Hsen-Lin Wu, Hsin-chu, TAIWAN; Tyng-Hao Hsu, Hsin-chu, TAIWAN; "CONTINUING DATA "** "This applic claims benefit of 60/450,177 02/26/2003 "FOREIGN APPLICATIONS "** "FOREIGN APPLICATIONS "** "STATE OR SHEETS TOTAL STATE OR COUNTRY TAIWAN 2 2 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	SERIAL NUMBER 10/781,107	FILING OR 371(c) DATE 02/18/2004 RULE	c	382	GROUP ART UNIT 2624		ATTORNEY DOCKET NO. N1085-00145			
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